Searched

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Application/Control No.

Applicant(s)/Patent Under Reexamination

09667003

CHOI ET AL.

Examiner

Nguyen, Jennifer T

Art Unit

2629

	Class	SubClass	Date		Examiner
345		76,77,82,83,45,72	8/1/06	JN	
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315	169.1-169.3	8/1/06	JN

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Search Notes



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